Se	arch	No	tes



Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/042,068	WAUKE, TOMOKUNI	
Examiner	Art Unit	
Dang D. Le	2834	

	SEAR	CHED	
Class	Subclass	Date	Examiner
310	49R 156.01- 156.84		
	152 10 46		
	216 254		
,	185		
	255 258 259	7/11/2006	DL

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
all	all	7/11/2006	DL

SEARCH N (INCLUDING SEARC	IOTES CH STRATEGY)
	DATE	EXMR
interference search included	7/11/2006	DL